

Search Notes**Application/Control No.**

10/623,155

Examiner

Shin-Lin Chen

Applicant(s)/Patent under Reexamination

WANG ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
424	93.2		
435	320.1		
435	455		
536	23.5		
514	44	4/20/2006	<i>SLC</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Sequence search for SEQ ID No. 160 and 161, Oligo search, parents reviewed and updated.	4/20/2006	<i>SLC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner